

Description

The SX15G10GD uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

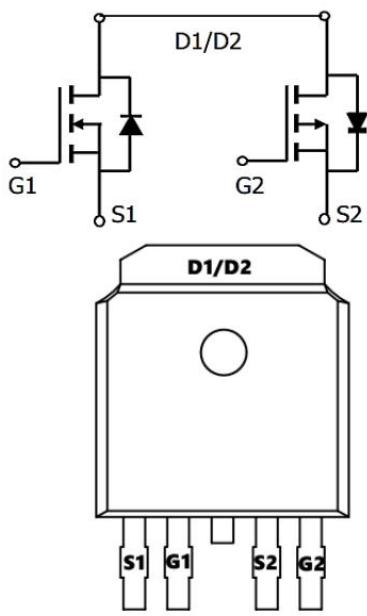
General Features

$V_{DS} = 100V$ $I_D = 17.8A$

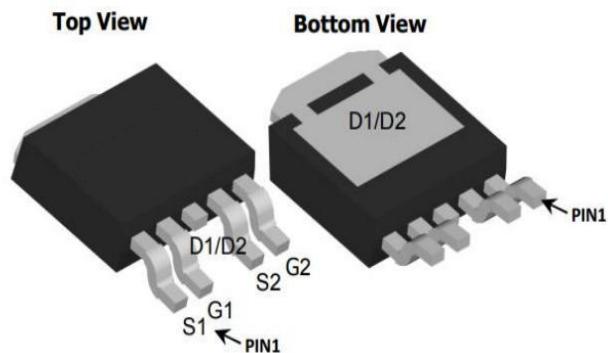
$R_{DS(ON)} < 120m\Omega$ @ $V_{GS}=10V$

$V_{DS} = -100V$ $I_D = -12.8A$

$R_{DS(ON)} < 290m\Omega$ @ $V_{GS}=-10V$

**Application**

BLDC

**Absolute Maximum Ratings ($T_c=25^\circ C$ unless otherwise noted)**

Symbol	Parameter	N-Ch	P-Ch	Units
V_{DS}	Drain-Source Voltage	100	-100	V
V_{GS}	Gate-Source Voltage	± 20	± 20	V
$I_D @ T_c=25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^1$	17.8	12.8	A
$I_D @ T_c=100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^1$	8.9	-7.5	A
I_{DM}	Pulsed Drain Current ²	52.5	-38.4	A
EAS	Single Pulse Avalanche Energy ³	28	18	mJ
I_{AS}	Avalanche Current	7	6	A
$P_D @ T_c=25^\circ C$	Total Power Dissipation ⁴	23	21.3	W
T_{STG}	Storage Temperature Range	-55 to 150		°C
T_J	Operating Junction Temperature Range	-55 to 150		°C
$R_{\theta JA}$	Thermal Resistance Junction-Ambient ¹	62.5		°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case ¹	5.4		°C/W

N-Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
V(BR)DSS	Drain-Source Breakdown Voltage	VGS=0V, ID=250μA	100	113	-	V
IDSS	Zero Gate Voltage Drain Current	VDS=100V, VGS=0V,	-	-	1.0	μA
IGSS	Gate to Body Leakage Current	VDS=0V, VGS=±20V	-	-	±100	nA
VGS(th)	Gate Threshold Voltage	VDS=VGS, ID=250μA	1.2	2.0	2.5	V
RDS(on)	Static Drain-Source on-Resistance note3	VGS=10V, ID=5A	-	85	120	mΩ
		VGS=4.5V, ID=3A	-	95	150	mΩ
g _{fs}	Forward Transconductance	V DS =5V , I D =5A		14		S
RG	Gate Resistance	VDS = 0V, VGS =0V,f=1MHz		3		Ω
Ciss	Input Capacitance	VDS=15V, VGS=0V, f=1.0MHz	-	1100	-	pF
Coss	Output Capacitance		-	55	-	pF
Crss	Reverse Transfer Capacitance		-	40	-	pF
Qg	Total Gate Charge	VDS=50V, ID=5A, VGS=10V	-	11.9	-	nC
Qgs	Gate-Source Charge		-	2.8	-	nC
Qgd	Gate-Drain("Miller") Charge		-	1.7	-	nC
td(on)	Turn-on Delay Time	VDS=30V, ID=5A, RG=1.8Ω, VGS=10V	-	3.8	-	ns
tr	Turn-on Rise Time		-	25.8	-	ns
td(off)	Turn-off Delay Time		-	16	-	ns
tf	Turn-off Fall Time		-	8.8	-	ns
IS	Continuous Source Current1,5	VG=VD=0V , Force Current	-	-	14.6	A
ISM	Pulsed Source Current2,5		-	-	25	A
VSD	Diode Forward Voltage2	VGS=0V, IS=10A	-	-	1.2	V

Note :

- 1、The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2、The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
- 3、The power dissipation is limited by 150°C junction temperature
- 4、The data is theoretically the same as I D and I DM , in real applications , should be limited by total power dissipation.

P-Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Typ	Max.	Units
BVDSS	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{V}, I_D = -250\mu\text{A}$	-100	-117	-	V
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = -100\text{V}, V_{GS} = 0\text{V}$	-	-	1	μA
IGSS	Gate to Body Leakage Current	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$	-	-	± 100	nA
VGS(th)	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$	-1.2	-1.85	-2.5	V
RDS(on)	Static Drain-Source On-Resistance ^{note1}	$V_{GS} = -10\text{V}, I_D = -5\text{A}$	-	235	290	mΩ
		$V_{GS} = -4.5\text{V}, I_D = -3\text{A}$	-	260	340	
Ciss	Input Capacitance	$V_{DS} = -50\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$	-	760	-	pF
Coss	Output Capacitance		-	25	-	pF
Crss	Reverse Transfer Capacitance		-	12	-	pF
Qg	Total Gate Charge	$V_{DD} = -50\text{V}, I_D = -5\text{A}, V_{GS} = -10\text{V}$	-	11.5	-	nC
Qgs	Gate-Source Charge		-	1.3	-	nC
Qgd	Gate-Drain("Miller") Charge		-	2.9	-	nC
td(on)	Turn-On Delay Time	$V_{DS} = -50\text{V}, I_D = -5\text{A}, R_G = 4.5\Omega, R_L = 25\Omega, V_{GEN} = -10\text{V}$	-	12	-	ns
t _r	Turn-On Rise Time		-	5	-	ns
td(off)	Turn-Off Delay Time		-	35	-	ns
t _f	Turn-Off Fall Time		-	20	-	ns
IS	Maximum Continuous Drain to Source Diode Forward Current		-	-	-12.8	A
VSD	Drain to Source Diode Forward Voltage	$V_{GS} = 0\text{V}, I_S = -1\text{A}$	-	-	-1.3	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0\text{V}, I_{SD} = -3\text{A}, dI/dt = 100\text{A}/\mu\text{s}$	-	25	-	nS
Q _{rr}	Reverse Recovery Charge		-	20	-	nC

Note :

- 1、The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2、The data tested by pulsed , pulse width .The EAS data shows Max. rating .
- 3、The power dissipation is limited by 175°C junction temperature
- 4、EAS condition: $T_J=25^\circ\text{C}$, $V_{DD}= -24\text{V}$, $V_G= -10\text{V}$, $R_G=7\Omega$, $L=0.1\text{mH}$, $I_{AS}= -29.5\text{A}$
- 5、The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

N-Typical Characteristics

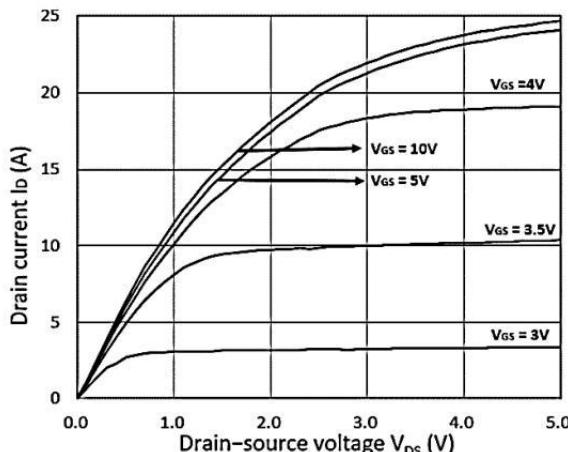


Figure 1. Output Characteristics

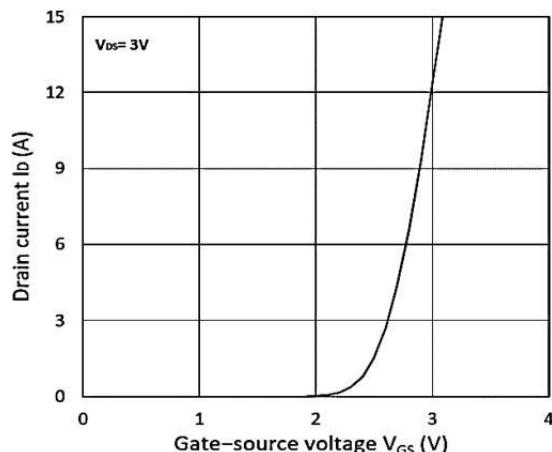


Figure 2. Transfer Characteristics

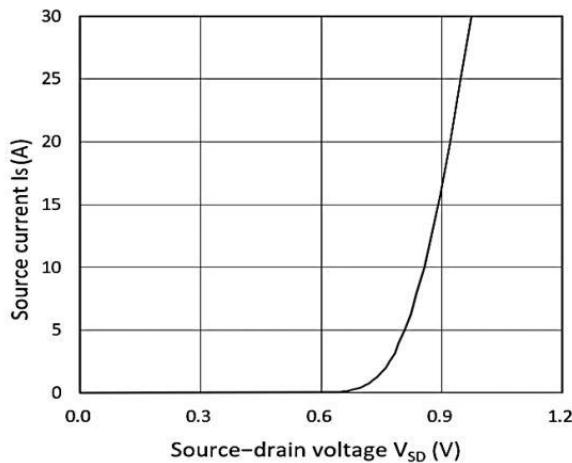


Figure 3. Forward Characteristics of Reverse

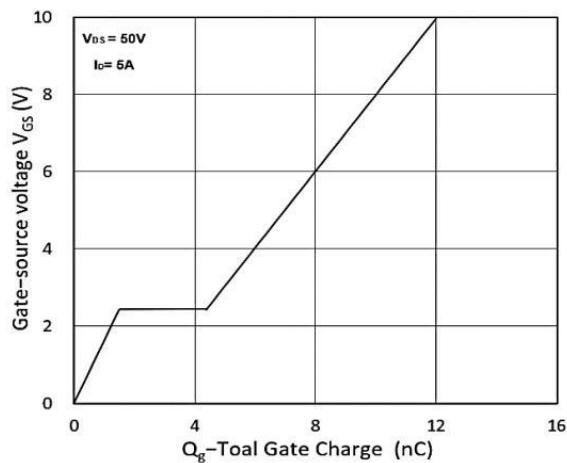


Figure 4. Gate Charge Characteristics

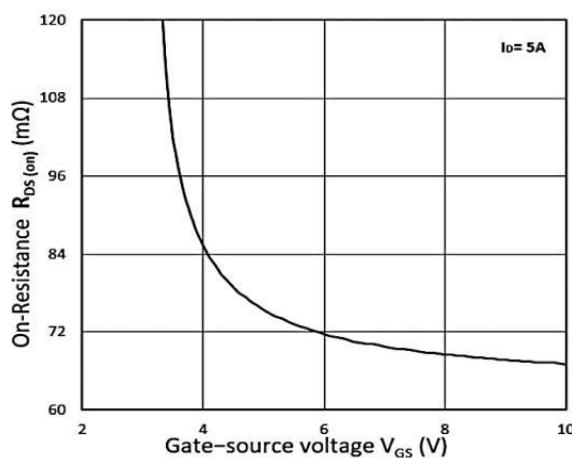


Figure 5. $R_{DS(on)}$ vs. V_{GS}

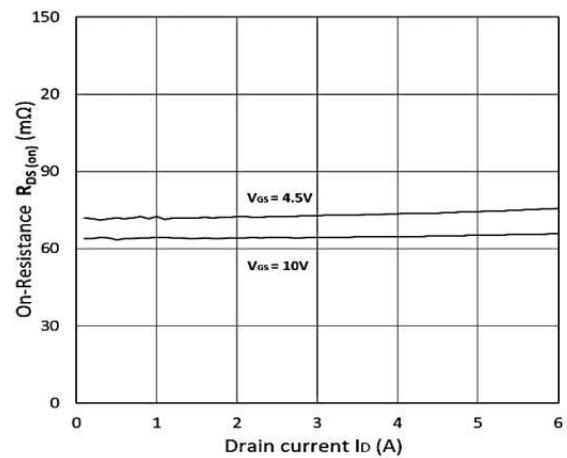
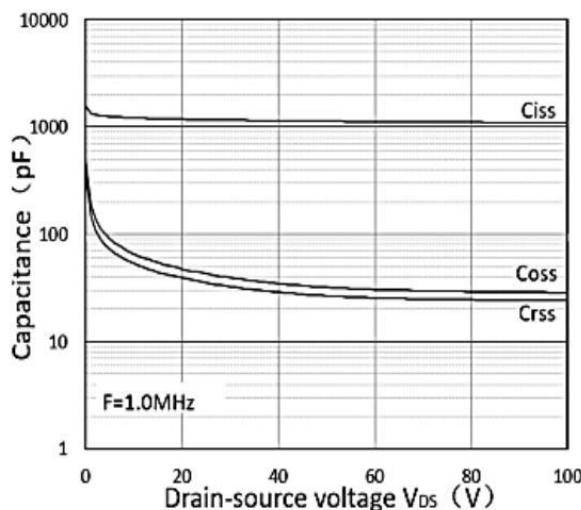
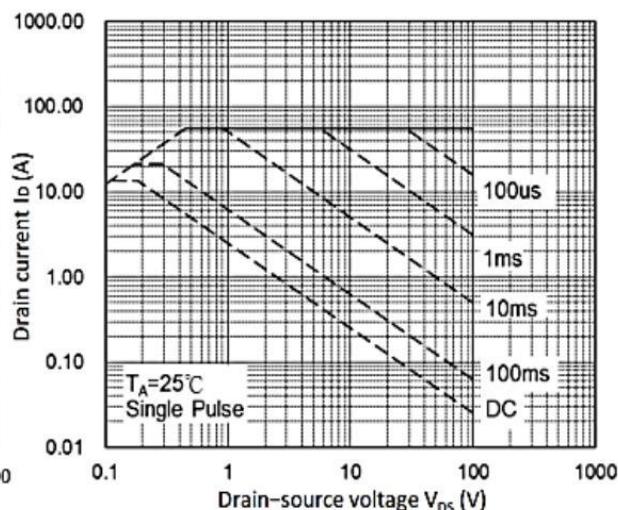
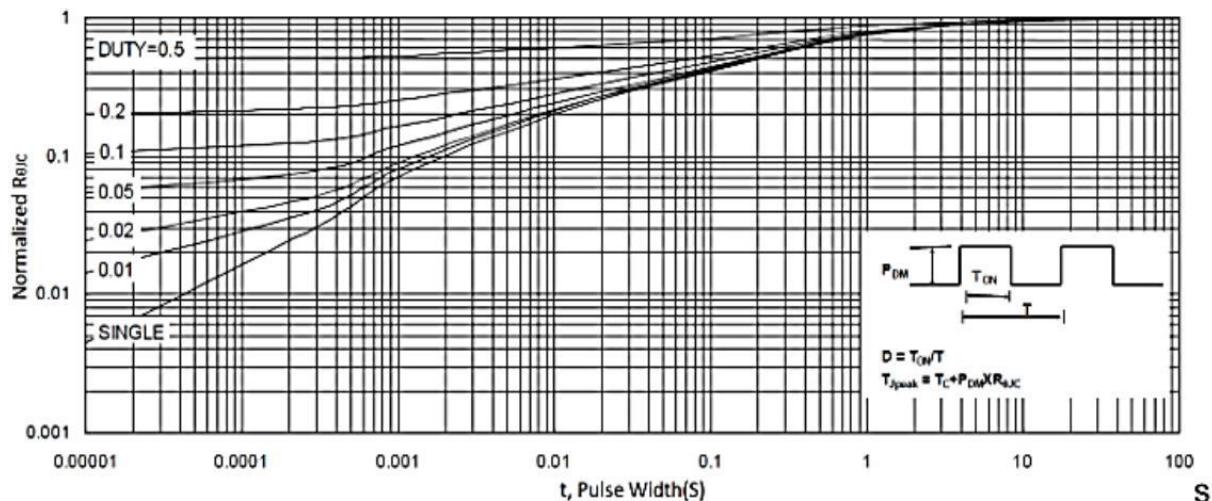
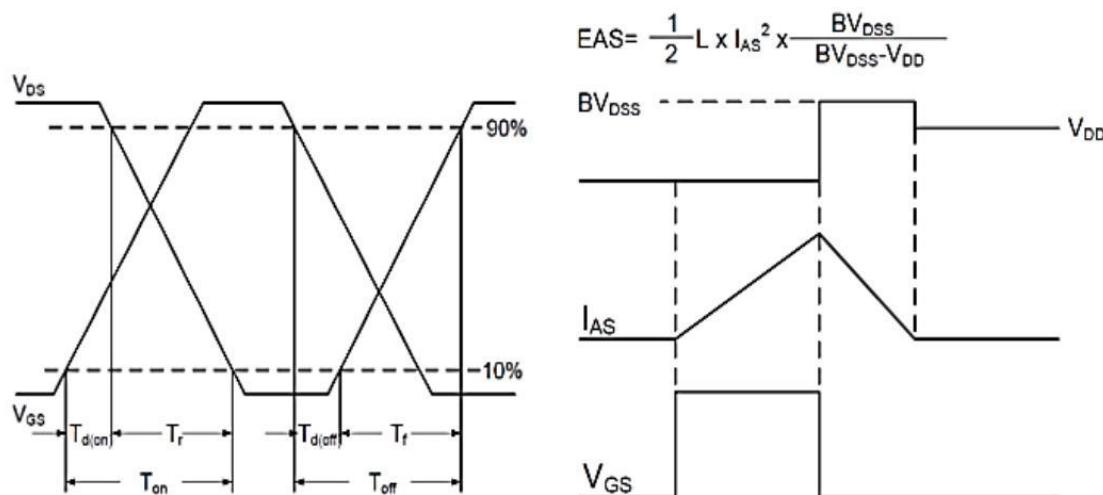


Figure 6. $R_{DS(on)}$ vs. I_D

N-Typical Characteristics**Figure 7. Capacitance Characteristics****Figure 8. Safe Operating Area****Figure 9. Normalized Maximum Transient Thermal Impedance****Figure 10. Switching Time Waveform****Figure 11. Unclamped Inductive Switching Waveform**

P-Typical Characteristics

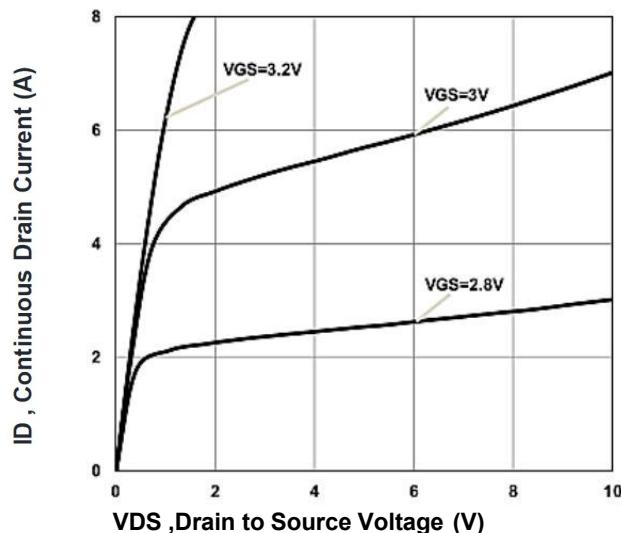


Figure 1. Typical Output Characteristics

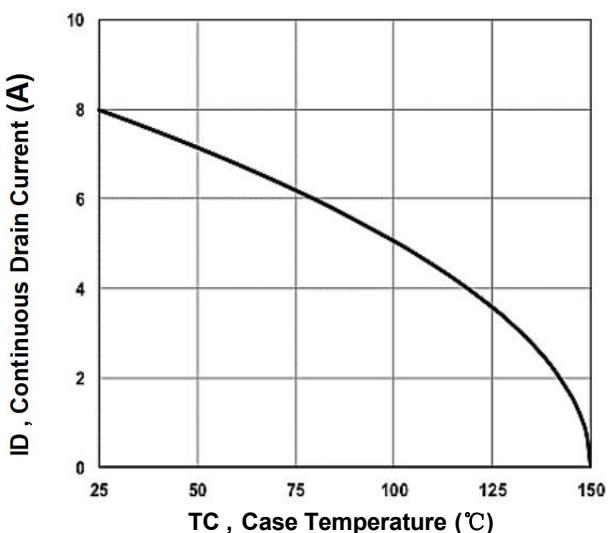


Figure 2. Continuous Drain Current vs. TC

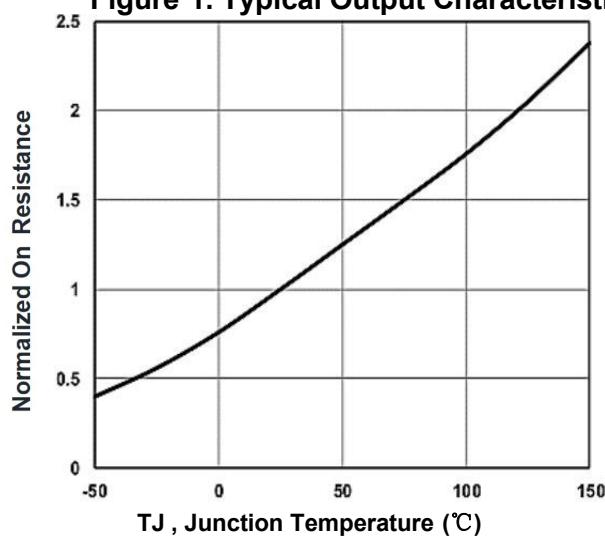


Figure 3. Normalized RD_{SON} vs. TJ

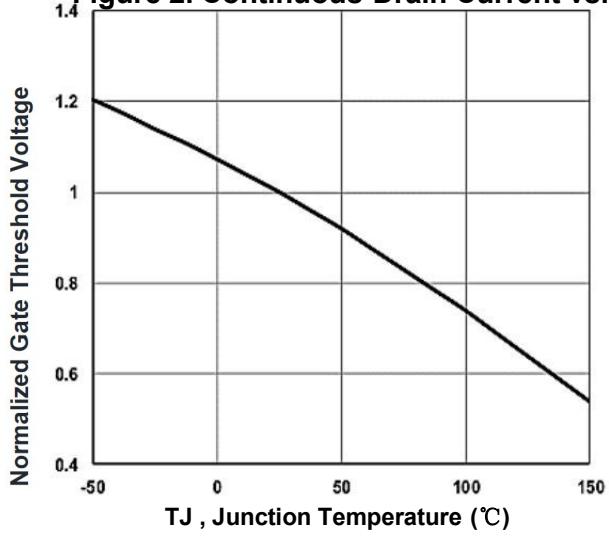


Figure 5. Normalized V_{th} vs. T

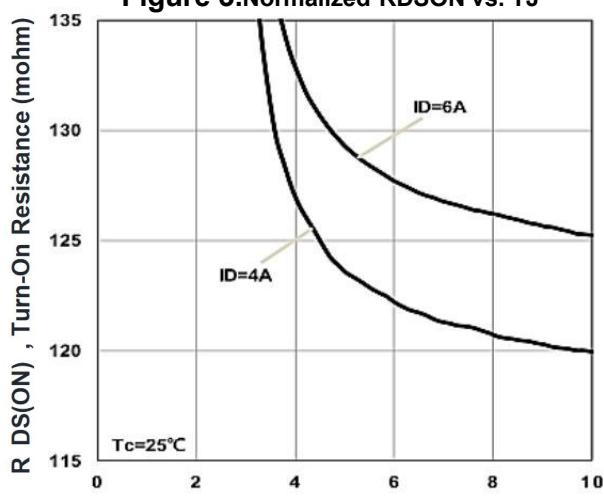


Figure 6. Turn-On Resistance vs. VGS

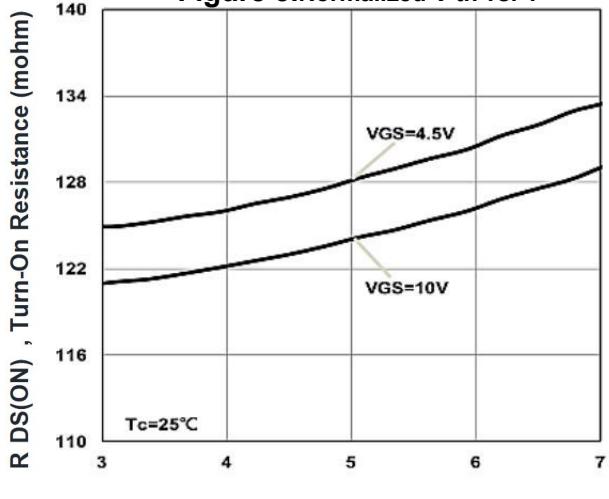
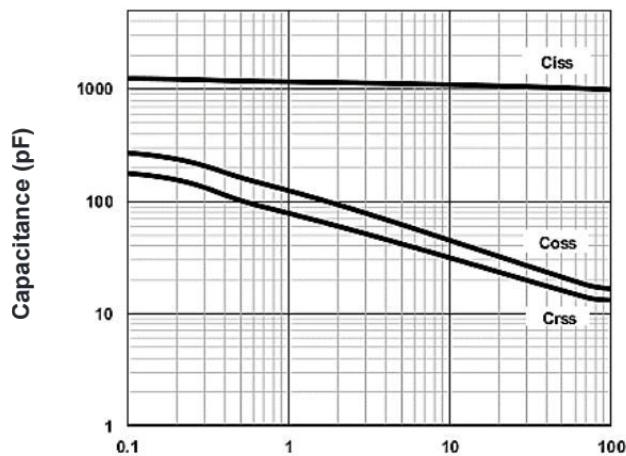
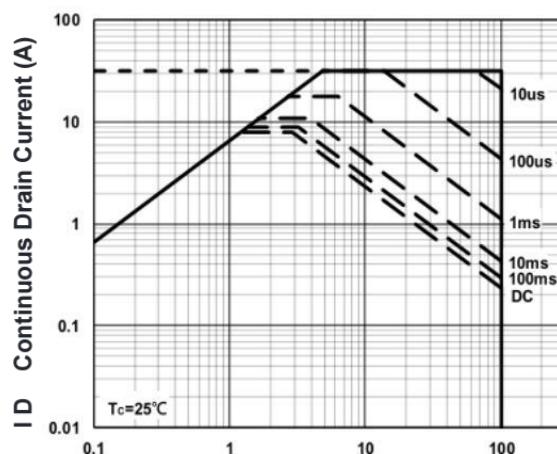


Figure 7. Turn-On Resistance vs. ID

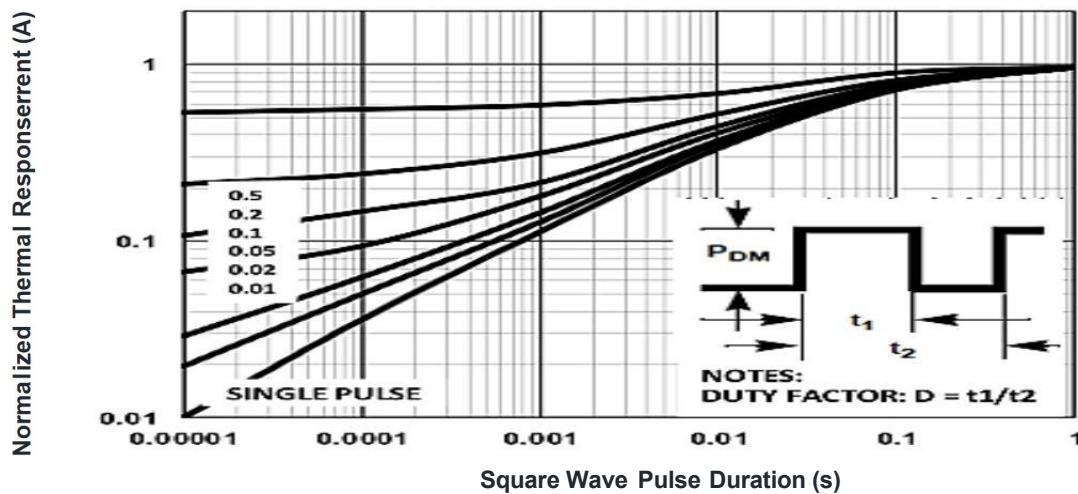
P-Typical Characteristics



V_{DS} , Drain to Source Voltage (V)
Figure 8.Capacitance Characteristics



V_{DS} , Drain to Source Voltage (V)
Figure 9.Maximum Safe Operation Area



Square Wave Pulse Duration (s)
Figure 10.Normalized Transient Impedance

$$\text{EAS} = \frac{1}{2} L \times I_{AS}^2 \times \frac{BV_{DSS}}{BV_{DSS} - V_{DD}}$$

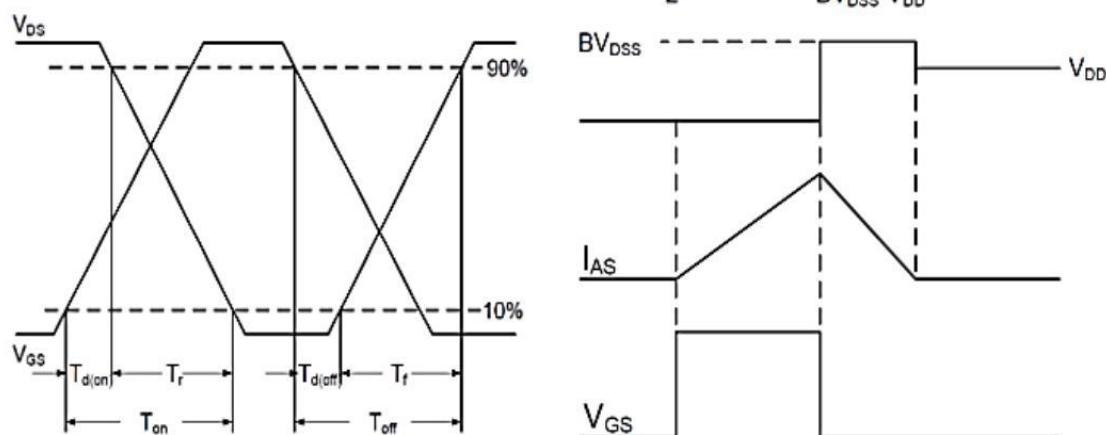
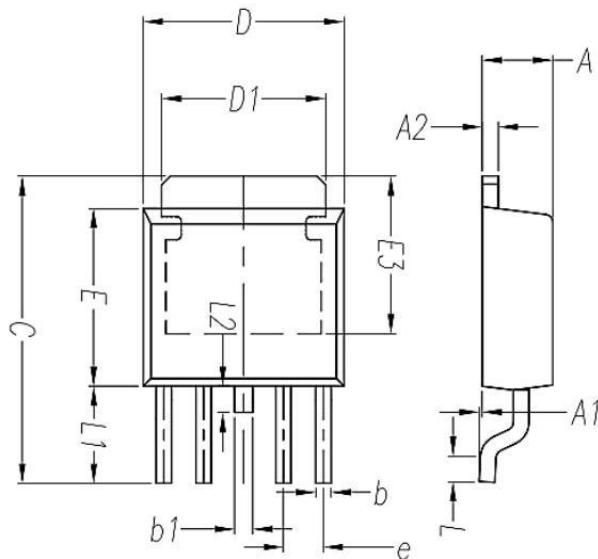


Figure 10. Switching Time Waveform

Figure 11. Unclamped Inductive Switching Waveform

Package Mechanical Data-TO-252-4L-Duble-DX



Symbol	Common		
	mm		
	Mim	Nom	Max
D	6.30	6.55	6.80
D1	4.80	5.35	5.90
C	9.70	10.00	10.30
E	5.90	6.10	6.30
E3	4.50	5.15	5.80
L	0.90	1.35	1.80
L1	2.60	2.85	3.05
L2	0.50	0.85	1.20
b	0.30	0.50	0.70
b1	0.40	0.60	0.80
A	2.10	2.30	2.50
A2	0.40	0.53	0.65
A1	0.00	0.10	0.20
e	1.17	1.27	1.37

Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
TAPING	TO-252-4L		2500